

Search Notes

Application/Control No.

10/055,526

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2623

SEARCHED

Class	Subclass	Date	Examiner
725	118- 120,127,1 28,149	7/19/2006	A.S

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR